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Substitute for form 1449A/B/PTO				Complete If Known	
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				First Named Inventor	Suk-Hun LEE
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				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	3449-0570PUS1

*MR  
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U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number-Kind Code <sup>2</sup> (#known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
<i>SM</i>	AA**	US-2002/195505-A	12-26-2002	Edmond et al.	<i>2002/0195505</i>

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> -Number-Kind Code <sup>4</sup> (#known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
<i>SM</i>	BA**	WO-98/31055-A1	07-16-1998		
<i>SM</i>	BB**	WO-02/103814-A1	12-27-2002		
<i>SM</i>	BC**	JP-8-264894-A	10-11-1996		
<i>SM</i>	BD**	KR-2002-79659-A	10-19-2002		
<i>SM</i>	BE**	KR-2004-42311-A	05-20-2004		

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Examiner Signature	<i>SM</i>	Date Considered	12-22-07
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